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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re the Application of:

MIRKIN et al.

Serial No.: 09/866,533

Filed: May 24, 2001

Atty. File No.: 4183-1-1

For: "METHODS UTILIZING SCANNING  
PROBE MICROSCOPE TIPS AND  
PRODUCTS THEREFOR OR  
PRODUCED THEREBY"

) Group Art Unit:

) Examiner:

) INFORMATION DISCLOSURE  
) STATEMENT

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Pursuant to Applicants' duty of disclosure under 37 CFR § 1.56 and 37 CFR §§ 1.97-1.98, Applicants hereby submit the enclosed PTO Form 1449. All of the documents identified herein, except one, have been submitted in U.S. Patent Application Serial No. 09/477,997, and since the above-identified patent application is a continuation-in-part thereof, copies of these documents are not being submitted under 37 CFR § 1.98(d). A copy of the one additional document is enclosed.

Applicants do not admit that any of the listed documents, alone or in any combination, are considered to be material to patentability as defined in 37 CFR § 1.56(b). Moreover, the inclusion of these documents is not to be construed as an admission by Applicants that each such document is prior art as to the above-identified patent application.

Respectfully submitted,

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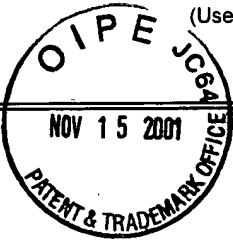
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	APPLICANT MIRKIN et al.	
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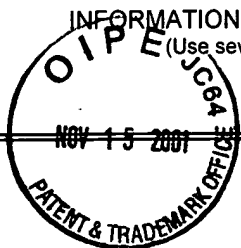


## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROP.
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	2	4,479,831	10/30/84	Sandow et al.	148	1.5	
	3	5,138,174	8/11/92	Tang	250	492.3	
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	8	5,345,815	9/13/94	Albrecht et al.	73	105	
	9	5,354,985	10/11/94	Quate	250	234	
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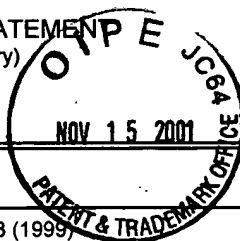
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION	
							YES	NO
	25	WO 00/04382	1/2000	PCT				
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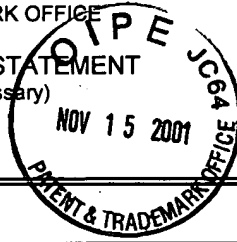
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